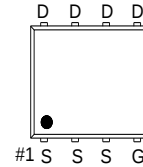
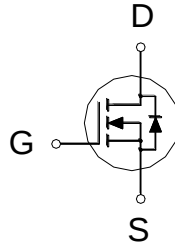



PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
30V	9m Ω	33A



G : GATE
D : DRAIN
S : SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current ³	$T_C = 25\text{ }^{\circ}\text{C}$	I_D	33	A
	$T_C = 100\text{ }^{\circ}\text{C}$		21	
	$T_A = 25\text{ }^{\circ}\text{C}$		10.6	
	$T_A = 70\text{ }^{\circ}\text{C}$		8.5	
Pulsed Drain Current ¹		I_{DM}	100	
Avalanche Current		I_{AS}	20	
Avalanche Energy	$L = 0.1\text{mH}$	E_{AS}	20	mJ
Power Dissipation	$T_C = 25\text{ }^{\circ}\text{C}$	P_D	17.8	W
	$T_C = 100\text{ }^{\circ}\text{C}$		7	
	$T_A = 25\text{ }^{\circ}\text{C}$		1.8	
	$T_A = 70\text{ }^{\circ}\text{C}$		1.1	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$R_{\theta JA}$		68	$^{\circ}\text{C} / \text{W}$
Junction-to-Case	$R_{\theta JC}$		7	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}\text{C}$.

³Package limitation current is 13A

ELECTRICAL CHARACTERISTICS ($T_j = 25\text{ }^{\circ}\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.3	1.8	2.3	

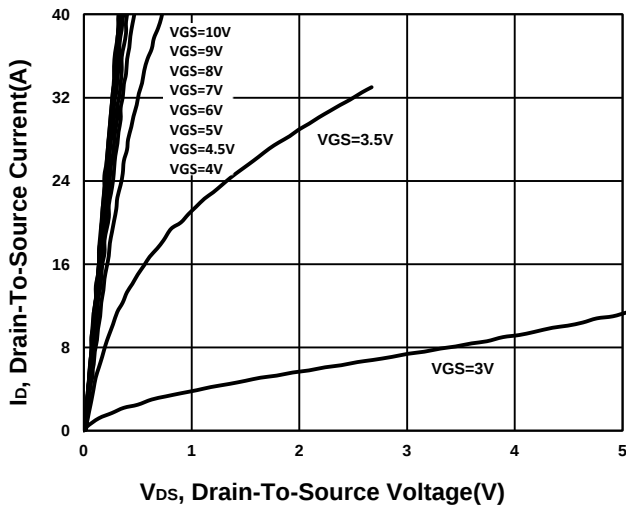
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 24V, V _{GS} = 0V			1	μA
		V _{DS} = 20V, V _{GS} = 0V, T _J = 55 °C			10	
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} = 4.5V, I _D = 10A		9.9	12	mΩ
		V _{GS} = 10V, I _D = 10A		7.4	9	
Forward Transconductance ¹	g _{fs}	V _{DS} = 10V, I _D = 10A		34		S
DYNAMIC						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 15V, f = 1MHz		774		pF
Output Capacitance	C _{oss}			139		
Reverse Transfer Capacitance	C _{rss}			81		
Gate Resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1MHz		3.1		Ω
Total Gate Charge ²	Q _{g(VGS=10V)}	V _{DS} = 15V , I _D = 10A		15.5		nC
	Q _{g(VGS=4.5V)}			8.3		
Gate-Source Charge ²	Q _{gs}			2.2		
Gate-Drain Charge ²	Q _{gd}			4.4		
Turn-On Delay Time ²	t _{d(on)}	V _{DD} = 15V I _D ≅ 10A, V _{GEN} = 10V, R _G =6Ω		23		nS
Rise Time ²	t _r			20		
Turn-Off Delay Time ²	t _{d(off)}			40		
Fall Time ²	t _f			20		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _J = 25 °C)						
Continuous Current ³	I _S				14.8	A
Forward Voltage ¹	V _{SD}	I _F = 10A, V _{GS} = 0V			1.2	V
Reverse Recovery Time	t _{rr}	I _F = 10A , dI _F /dt = 100A / μS		9.5		nS
Reverse Recovery Charge	Q _{rr}			1.4		nC

¹Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.

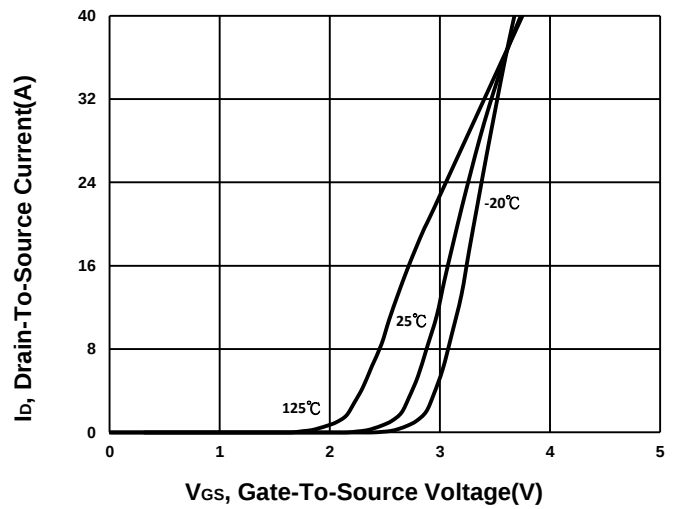
²Independent of operating temperature.

³Package limitation current is 13A

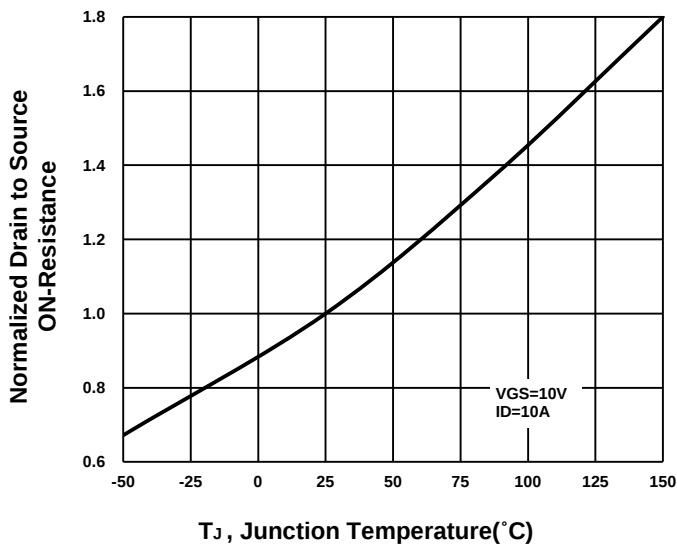
Output Characteristics



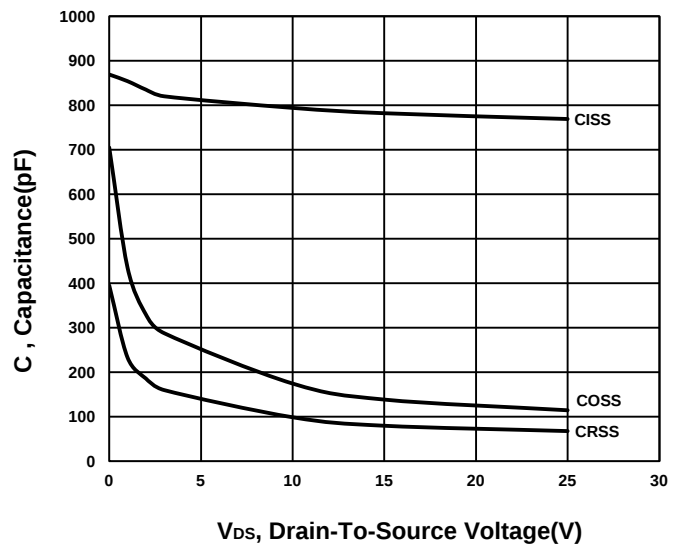
Transfer Characteristics



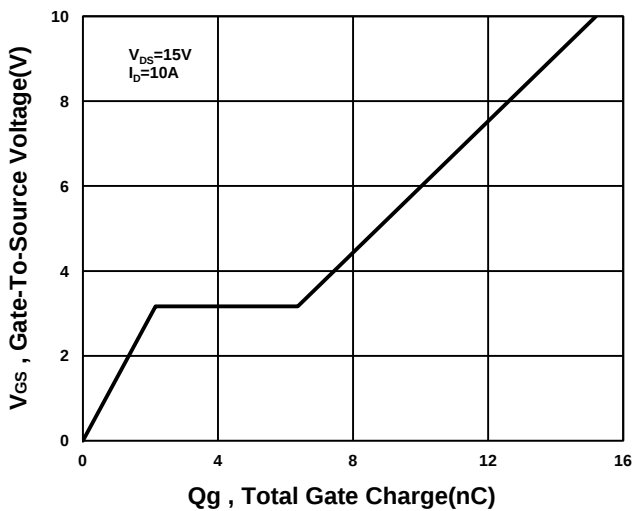
On-Resistance VS Temperature



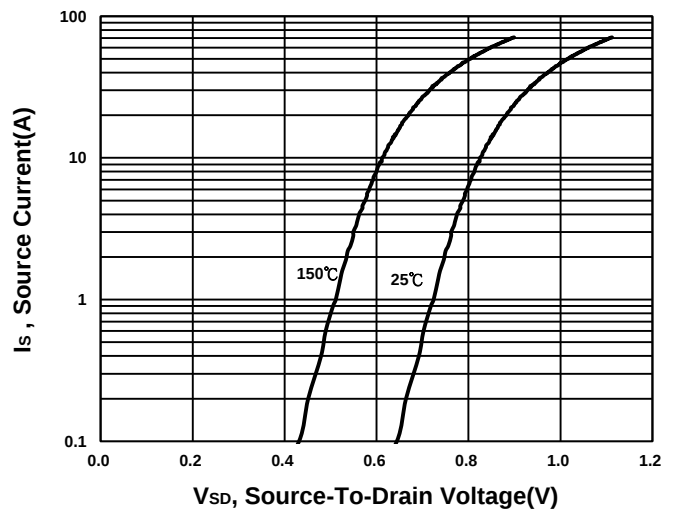
Capacitance Characteristic



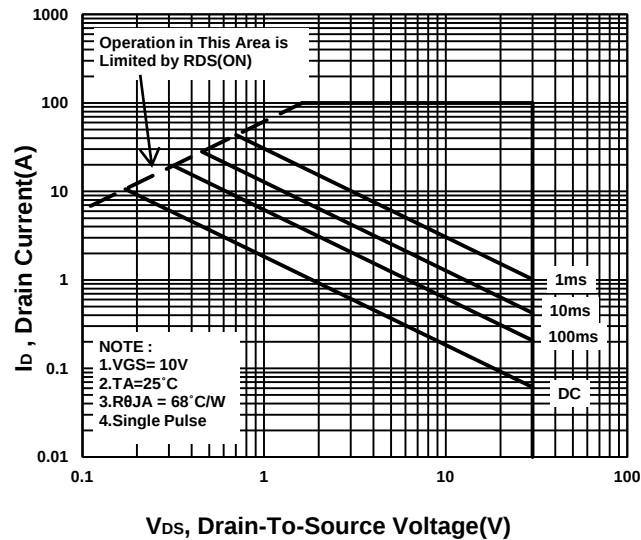
Gate charge Characteristics



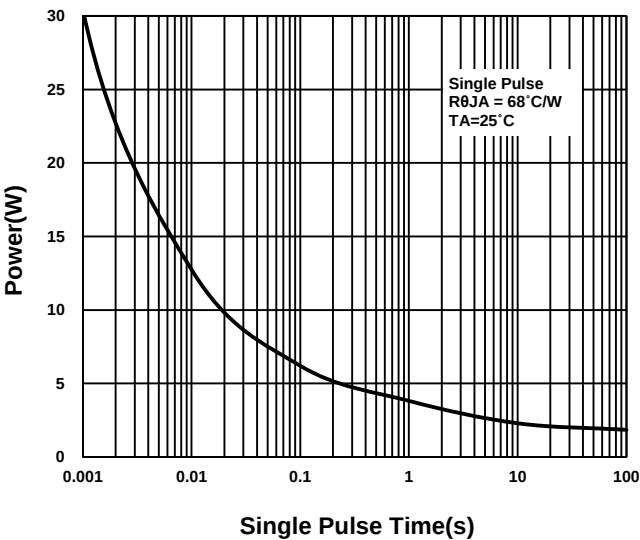
Source-Drain Diode Forward Voltage



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

